

**PCN 18\_0139 QUALIFICATION SUMMARY**

**OP471S AEROSPACE MODELS CHANGE OF WAFER DIAMETER**

<b>TEST NAME</b>	<b>CONDITION</b>	<b>MATERIAL ID</b>	<b>RESULTS</b>
High Temp Operating Life Test	MIL-STD-883, TM1005 TA = +125C, 1000 Hrs.	Wafer Lot 701611	45(0) Pass
Total Ionizing Dose (Radiation Hardness)	MIL-STD-883, TM1019 Condition A 100 Krads	Wafer Lot 701611 Wafer Nos. 7,8,9,10,11	4 die per wafer 20(0) Pass